

<b>Notice of References Cited</b>	Application/Control No. 10/810,574		Applicant(s)/Patent Under Reexamination LEE, BYUNG-PYLL	
	Examiner Hau V. Phan		Art Unit 3618	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2,993,721	07-1961	BOWMAN CONRAD K	280/759
*	B	US-5,000,333	03-1991	Petrelli, Luigi	220/890
*	C	US-5,024,383	06-1991	Vaschetto et al.	239/284.1
*	D	US-5,460,420	10-1995	Perkins et al.	293/106
*	E	US-2,877,485	03-1959	OISHEI JOHN R	15/250.02
*	F	US-2,889,569	06-1959	RIESTER WILLIAM C	15/250.02
*	G	US-5,853,025	12-1998	Daneshvar, Yousef	239/284.1
*	H	US-6,508,414	01-2003	Matsumoto et al.	239/284.1
*	I	US-2,784,876	03-1957	BERNARD PARKES ERIC	239/284.1
*	J	US-6,726,122	04-2004	Zimmer, Joachim	239/284.1
*	K	US-2004/0142232	07-2004	Risca et al.	429/100
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

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